

N-Channel 40-V (D-S) Fast Switching MOSFET



RoHS
COMPLIANT

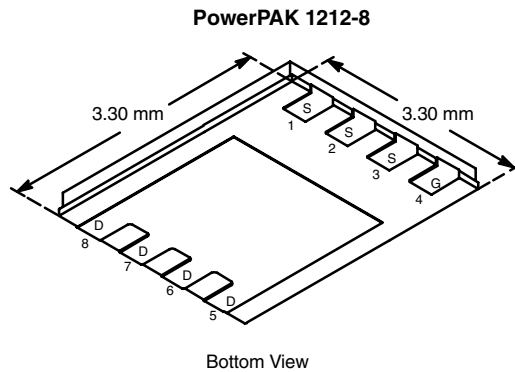
| PRODUCT SUMMARY | | | |
|---------------------|---------------------------------|--------------------|----------------------|
| V _{DS} (V) | r _{DS(on)} (Ω) | I _D (A) | Q _g (Typ) |
| 40 | 0.0078 @ V _{GS} = 10 V | 16.4 | 15 |
| | 0.010 @ V _{GS} = 4.5 V | 14.5 | |

FEATURES

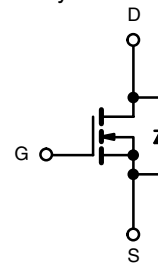
- TrenchFET® Power MOSFET
- New Low Thermal Resistance PowerPAK® Package with Low 1.07-mm Profile
- PWM Optimized
- 100% R_g Tested

APPLICATIONS

- Synchronous Rectification
- Intermediate Switch
- Synchronous Buck



Ordering Information: Si7116DN-T1—E3 (Lead (Pb)-Free)



| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C UNLESS OTHERWISE NOTED) | | | | | |
|--|------------------------|-----------------------------------|------------|--------------|------|
| Parameter | | Symbol | 10 secs | Steady State | Unit |
| Drain-Source Voltage | | V _{DS} | 40 | | V |
| Gate-Source Voltage | | V _{GS} | ± 20 | | |
| Continuous Drain Current (T _J = 150 °C) ^a | T _A = 25 °C | I _D | 16.4 | 10.5 | A |
| | T _A = 70 °C | | 13.1 | 8.4 | |
| Pulsed Drain Current | | I _{DM} | 60 | | |
| Continuous Source Current (Diode Conduction) ^a | | I _S | 3.2 | 1.3 | |
| Avalanche Current | L = 0.1 mH | I _{AS} | 15 | | |
| Avalanche Energy | | E _{AS} | 11 | | mJ |
| Maximum Power Dissipation ^a | T _A = 25 °C | P _D | 3.8 | 1.5 | W |
| | T _A = 70 °C | | 2.0 | 0.8 | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | -55 to 150 | | °C |
| Soldering Recommendations (Peak Temperature) ^{b,c} | | | 260 | | |

| THERMAL RESISTANCE RATINGS | | | | | |
|--|--------------|-------------------|---------|---------|------|
| Parameter | | Symbol | Typical | Maximum | Unit |
| Maximum Junction-to-Ambient ^a | t ≤ 10 sec | R _{thJA} | 24 | 33 | °C/W |
| | Steady State | | 65 | 81 | |
| Maximum Junction-to-Case (Drain) | | R _{thJC} | 1.9 | 2.4 | |

Notes

- Surface Mounted on 1" x 1" FR4 Board.
- See Solder Profile (<http://www.vishay.com/doc?73257>). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.



| MOSFET SPECIFICATIONS (T _J = 25 °C UNLESS OTHERWISE NOTED) | | | | | | |
|---|---------------------|--|-----|--------|--------|------|
| Parameter | Symbol | Test Condition | Min | Typ | Max | Unit |
| Static | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = 250 μA | 1.5 | | 2.5 | V |
| Gate-Body Leakage | I _{GSS} | V _{DS} = 0 V, V _{GS} = ±20 V | | | ±100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 40 V, V _{GS} = 0 V | | | 1 | μA |
| | | V _{DS} = 40 V, V _{GS} = 0 V, T _J = 55 °C | | | 5 | |
| On-State Drain Current ^a | I _{D(on)} | V _{DS} ≥ 5 V, V _{GS} = 10 V | 40 | | | A |
| Drain-Source On-State Resistance ^a | r _{DS(on)} | V _{GS} = 10 V, I _D = 16.4 A | | 0.0065 | 0.0078 | Ω |
| | | V _{GS} = 4.5 V, I _D = 14.5 A | | 0.0083 | 0.010 | |
| Forward Transconductance ^a | g _{fs} | V _{DS} = 15 V, I _D = 16.4 A | | 68 | | S |
| Diode Forward Voltage ^a | V _{SD} | I _S = 3.2 A, V _{GS} = 0 V | | 0.8 | 1.2 | V |
| Dynamic^b | | | | | | |
| Total Gate Charge | Q _g | V _{DS} = 20 V, V _{GS} = 4.5 V, I _D = 16.4 A | | 15 | 23 | nC |
| Gate-Source Charge | Q _{gs} | | | 6.7 | | |
| Gate-Drain Charge | Q _{gd} | | | 5.1 | | |
| Gate-Resistance | R _g | f = 1 MHz | 0.7 | 1.4 | 2.1 | Ω |
| Turn-On Delay Time | t _{d(on)} | V _{DD} = 20 V, R _L = 20 Ω I _D ≅ 1 A, V _{GEN} = 10 V, R _g = 6 Ω | | 10 | 15 | ns |
| Rise Time | t _r | | | 10 | 15 | |
| Turn-Off Delay Time | t _{d(off)} | | | 36 | 55 | |
| Fall Time | t _f | | | 10 | 15 | |
| Source-Drain Reverse Recovery Time | t _{rr} | I _F = 3.2 A, di/dt = 100 A/μs | | 30 | 60 | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 3.2 A, di/dt = 100 A/μs | | 26 | 52 | nc |

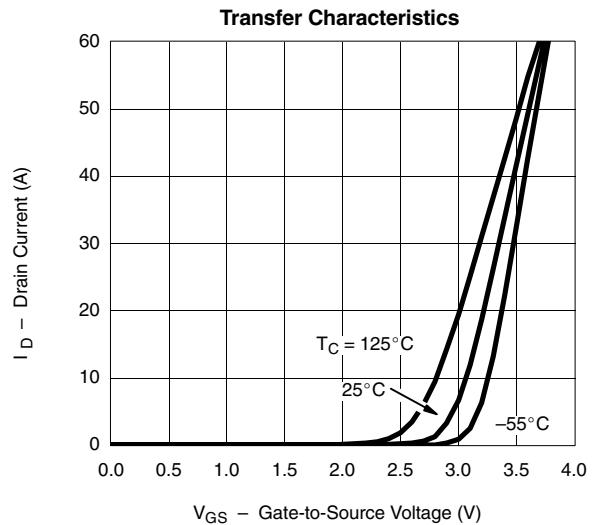
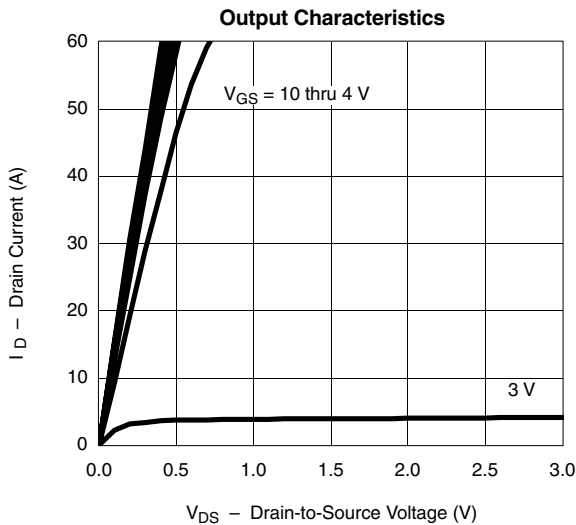
Notes

a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2%.

b. Guaranteed by design, not subject to production testing.

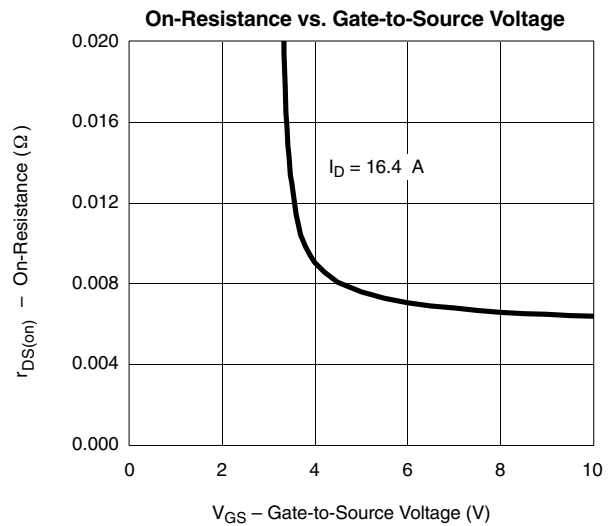
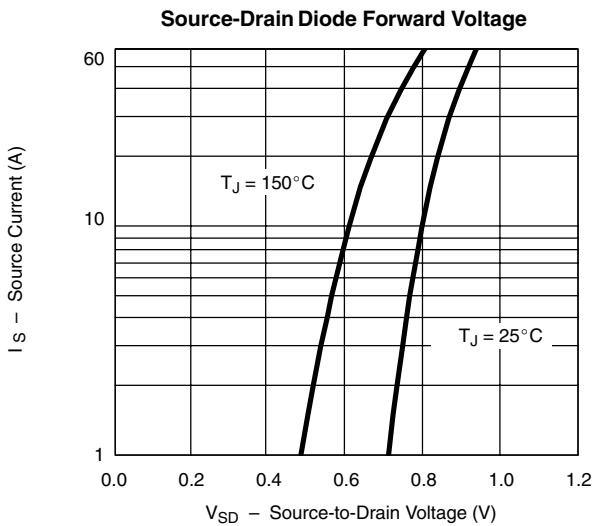
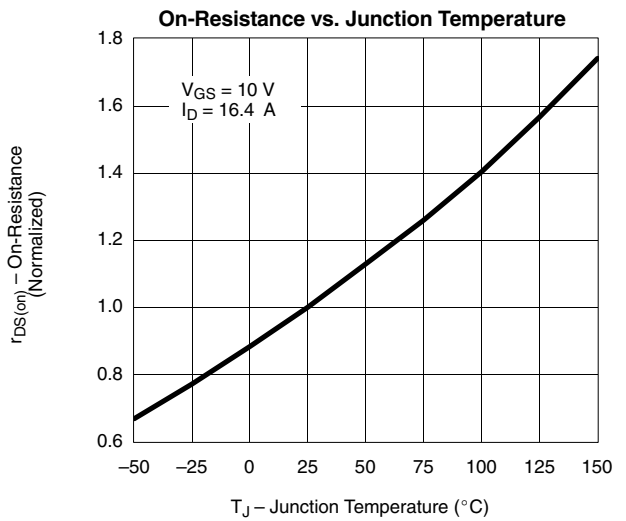
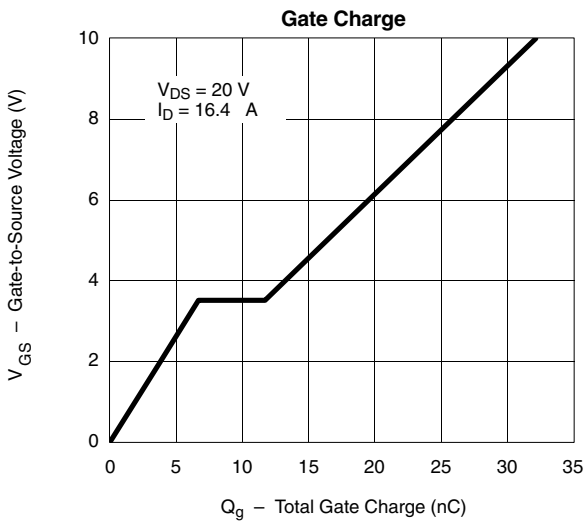
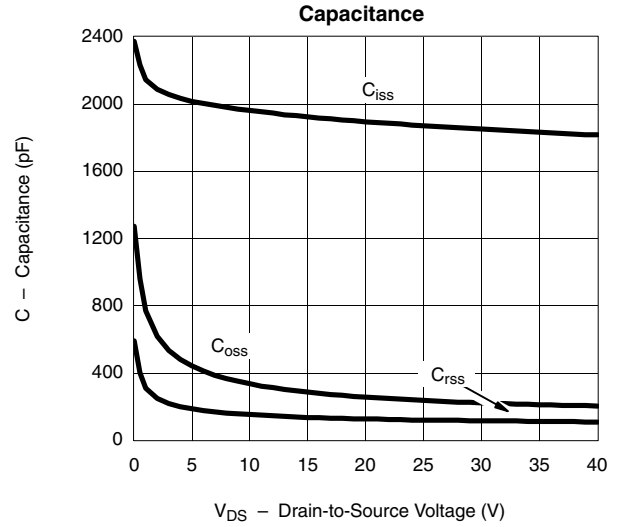
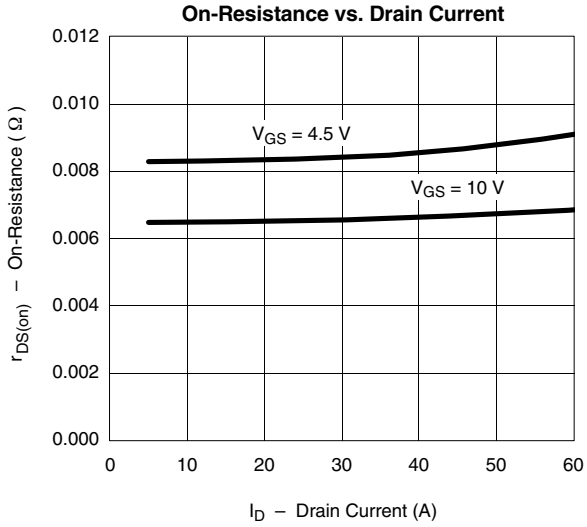
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)

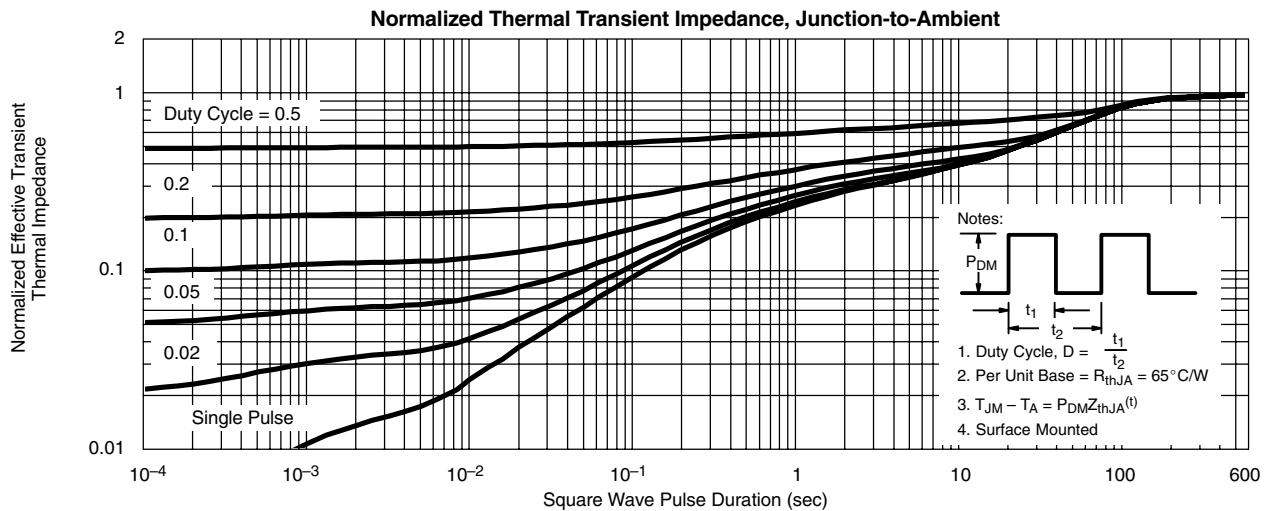
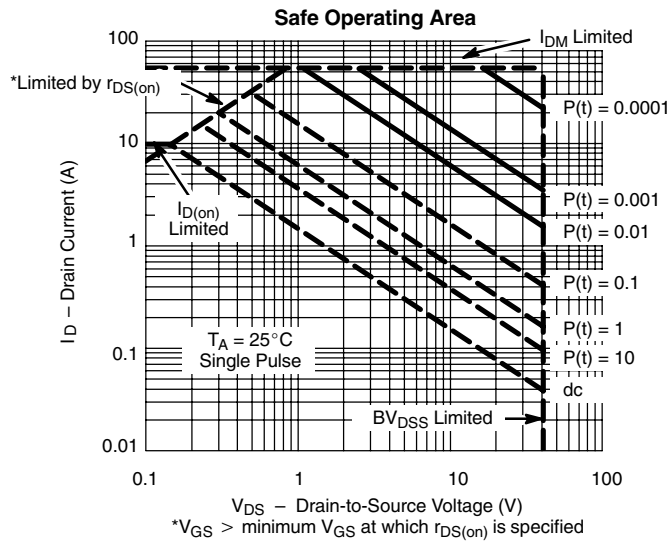
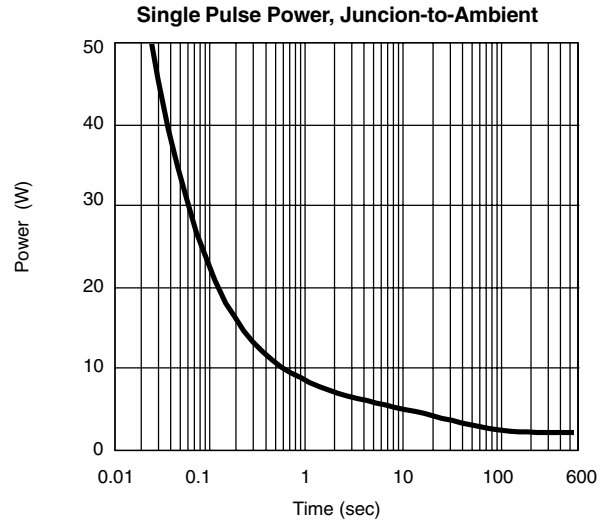
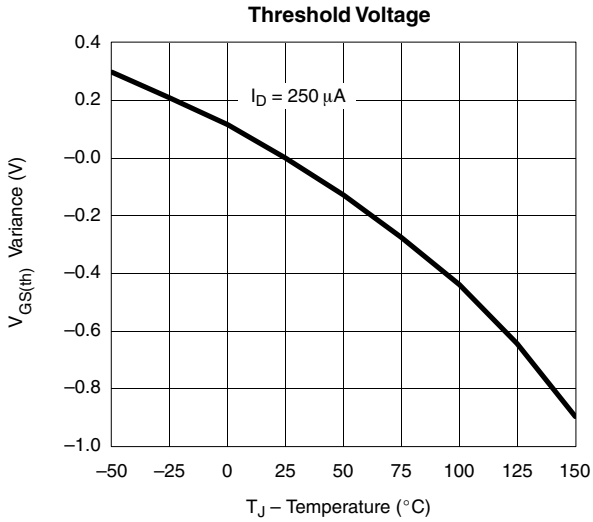




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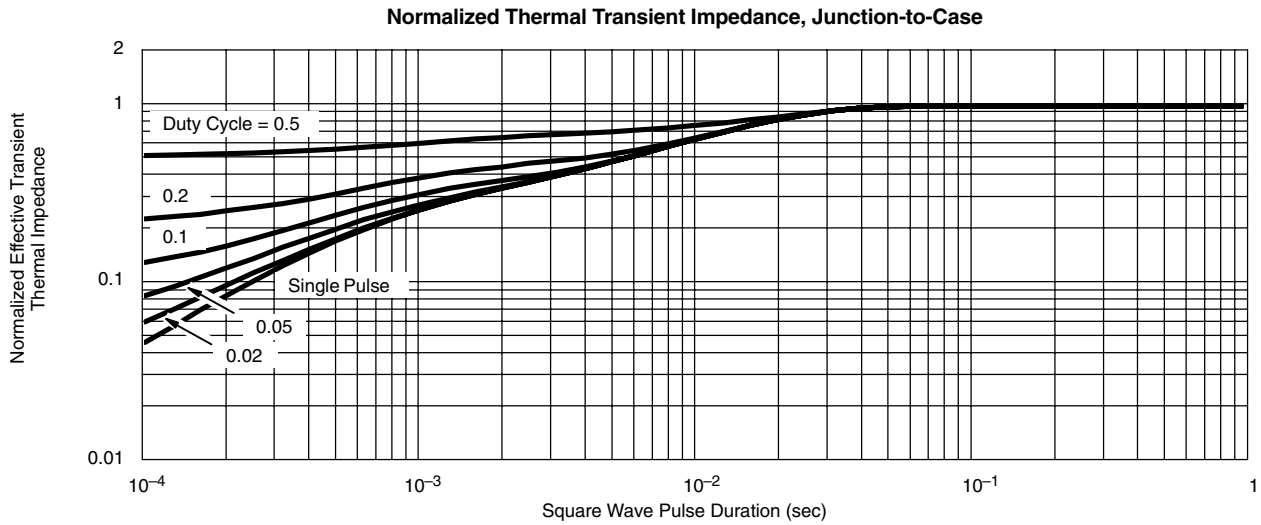


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